





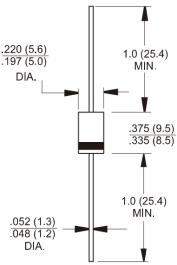
3.0AMPS Glass Passivated Fast Recovery Rectifiers

DO-201AD



Features

- Glass passivated chip junction
- ♦ High efficiency, Low VF
- High current capability
- ♦ High reliability
- ♦ High surge current capability
- ♦ Low power loss
- Green compound with suffix "G" on packing code & prefix "G" on datecode



Dimensions in inches and (millimeters)

Marking Diagram FR30XG = Specific Device Code G = Green Compound Y = Year FR30XG SGYWW = Work Week

Mechanical Data

- Cases: Molded plastic
- Lead: Pure tin plated, lead free, solderable per MIL-STD-202, Method 208 guaranteed
- ♦ Polarity: Color band denotes cathode end
- High temperature soldering guaranteed: 260 ℃ /10s
 /.375", (9.5mm) lead lengths at 5 lbs, (2.3kg) tension
- ♦ Weight: 1.2 grams

Maximum Ratings and Electrical Characteristics

Rating at 25 °C ambient temperature unless otherwise specified.

Single phase, half wave, 60 Hz, resistive or inductive load.

For capacitive load, derate current by 20%

Type Number	Symbol	FR 301G	FR 302G	FR 303G	FR 304G	FR 305G	FR 306G	FR 307G	Units
Maximum Recurrent Peak Reverse Voltage	V_{RRM}	50	100	200	400	600	800	1000	V
Maximum RMS Voltage	V_{RMS}	35	70	140	280	420	560	700	V
Maximum DC Blocking Voltage	V_{DC}	50	100	200	400	600	800	1000	V
Maximum Average Forward Rectified Current .375 (9.5mm) Lead Length @ T_A =55 $^{\circ}$ C	I _{F(AV)}	3							Α
Peak Forward Surge Current, 8.3 ms Single Half Sinewave Superimposed on Rated Load (JEDEC method)	I _{FSM}	125							Α
Maximum Instantaneous Forward Voltage (Note 1) @ 3 A	V _F	1.3							V
Maximum DC Reverse Current at $\ \ \ \ \ \ \ \ \ \ $	I _R			5					uA
Rated DC Blocking Voltage @ T _A =125 °C	100						uA		
Maximum Reverse Recovery Time (Note 2)	Trr	150		250	500		nS		
Typical Junction Capacitance (Note 3)	Cj	30						pF	
Typical Thermal Resistance (Note 4)	$R_{\theta JA}$	35							°C/W
Operating Temperature Range	TJ	- 65 to + 150							οС
Storage Temperature Range	T _{STG}	- 65 to + 150							оС

Note 1: Pulse Test with PW=300 usec, 1% Duty Cycle

Note 2: Reverse Recovery Test Conditions: I_F =0.5A, I_R =1.0A, I_{RR} =0.25A

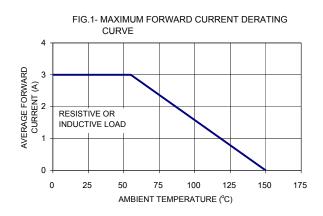
Note 3: Measured at 1 MHz and Applied Reverse Voltage of 4.0V D.C.

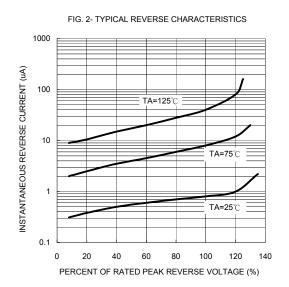
Note 4: Mount on Cu-Pad Size 16mm x 16mm on PCB

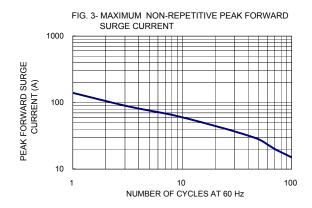
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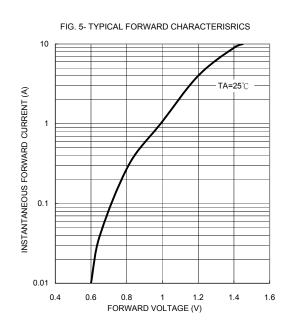


RATINGS AND CHARACTERISTIC CURVES (FR301G THRU FR307G)









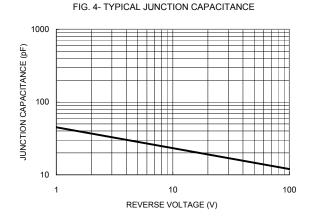


FIG.6- REVERSE RECOVERY TIME CHARACTERISTIC AND TEST CIRCUIT DIAGRAM

